

Search Notes

Application/Control No.

10/820,315

Examiner

Hieu Nguyen

Applicant(s)/Patent under
Reexamination

GREBENNIKOV ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	296	8/15/2005	HN
330	285	8/25/2005	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
NGUYEN KHANH V	8/29/2005	HN